

Docket No.: 4481-044

~~2-28-03~~
2-25-03
PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

David Martin Gee

Serial No. To Be Assigned

Filed: Concurrently Herewith

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Group Art Unit: Unknown

Examiner: Unknown

JC979 U.S. PTO
10/046812
01/17/02

For: FAULT TOLERANT ELECTRICAL CIRCUIT AND METHOD

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents
Washington, D. C. 20231

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Respectfully submitted,

LOWE HAUPTMAN GILMAN & BERNER, LLP

Allan M. Lowe

Allan M. Lowe
Registration No. 19,641

1700 Diagonal Road, Suite 310
Alexandria, Virginia 22314
(703) 684-1111
(703) 518-5499 Facsimile
AML/leb

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
4481-044

SERIAL NO.
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10/046812
10/17/02

APPLICANT
David Martin Gee

FILING DATE
Concurrently Herewith

GROUP
Unknown

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	5,618,752	04/08/97	GAUL			
	5,943,574	08/24/99	TEHRANI et al.			

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	0 924 823 A1	06/23/99	EPO			XX	
	6-69210	03/11/94	JAPAN				XX

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	(1) European Search Report.
	(2) English-language Patent Abstract of JP 6-69210.
	(3) English-language Patent Abstract of JP 2000 311316.
	(4) English-language Patent Abstract of JP 01 161860.

EXAMINER	DATE CONSIDERED
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.